



PATENT APPLICATION *JFW*

IN THE U.S. PATENT AND TRADEMARK OFFICE

Applicants : Hitoshi SATO et al  
: ROTATING MECHANISM OF BIAXIAL HINGE, AND  
PORTABLE TELEPHONE EQUIPPED WITH SAME

Serial No. : 10/549 538 Group: 2617

Confirmation No.: 3616

Filed : September 15, 2005 Examiner: Unknown

International Application No.: PCT/JP2004/015970

International Filing Date : October 21, 2004

Atty. Docket No.: 4700.P0316US

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

**FIRST CLASS MAILING CERTIFICATE**

Sir:

I hereby certify that this correspondence is being deposited with the United States Postal Service under 37 CFR 1.8 as first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on May 18, 2006.

  
Terryence F. Chapman

TFC/smd

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Correspondence: Information Disclosure Statement  
dated May 18, 2006  
including enclosures listed thereon

190.05/05



## PATENT APPLICATION

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## INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the provisions of Rules 1.97(e)(1) and 1.98, enclosed herewith is a copy of the European Patent Office Search Report, Form PTO-1449 and the references cited thereon. The relevance of these references is explained on the enclosed search report. Accordingly, further comment at this point in time should not be necessary.

I hereby certify that each item of information contained in this Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.

Further consideration is respectfully solicited.

Respectfully submitted,

TFC/smd

Terryence F. Chapman

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Encl: Copy of European Patent Office Search Report  
dated February 23, 2006 (3 pages)  
Form PTO-1449 and references cited thereon  
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INFORMATION  
DISCLOSURE  
CITATION  
MAY 22 2006

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PATENT TRADESMARK OFFICE  
Initials\* No.

U.S. PATENT DOCUMENTS			
Examiner Initials*	Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant
AA			
AB			
AC			
AD			
AE			
AF			
AG			
AH			
AI			
AJ			
AK			

## FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.	Country Code - Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Trans.
AL		EP 1 353 488	10-15-2003	MASATOMO et al	
AM		EP 1 288 414	03-05-2003	KANG et al	
AN					
AO					
AP					

## NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.	(Include Author, Title, Date, Pages, Etc.)
	AQ	
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EXAMINER SIGNATURE		DATE CONSIDERED

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.